

Search Notes

Application/Control No.

10/630,983

Examiner

Hai L. Nguyen

Applicant(s)/Patent under
Reexamination

KOIKE, HIDEHARU

Art Unit

2816

SEARCHED

Class	Subclass	Date	Examiner
327	551,552, 309-311, 313,318	5/18/2005	HLN
	319,321		
	327,328		
	379,180		
361	91.1,225		
257	355-357		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Shepardize Search	5/18/2005	HLN